

Search Notes

Application/Control No.

10/812,752

Examiner

Sunray Chang

Applicant(s)/Patent under
Reexamination

ERYUREK ET AL.

Art Unit

2121

SEARCHED

Class	Subclass	Date	Examiner
700	83,17	3/26/2007	SC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPAT, US_PGPUB, JPO, EPO, DERWENT, IBM_TDB) Text Search	3/26/2007	SC
IDS	3/26/2007	SC